Issue Classification

Application/Control No.	Applicant(s)/Patent under Reexamination
10/075,963	DAY, MARK
Examiner	Art Unit
Van Kim T. Nguyen	2151

ISSUE CLASSIFICATION

ORIGINAL		INTERNATIONAL CLASSIFICATION							
CLASS	SUBCLASS	CLAIMED					NON-CLAIMED		
709	203	G	06	F	15	/16			/

CROSS REFERENCES							/				/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
703	224	228					/				/
717	121	170					/				/
							/				/
							/				/
							/				/

(Assistant Examiner) Van Nguyen (Date) 1/23/07

(Legal Instruments Examiner) RWBrown 2-8-07 (Date)

ARIC ETIENNE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) (Date) 2/5/07

Total Claims Allowed: 21

O.G. Print Claim(s)	O.G. Print Fig.
1	2

☐ Claims renumbered in the same order as presented by applicant		☐ CPA	☐ T.D.	☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	(1)		31		61		91		121		151		181
2	2		32		62		92		122		152		182
3	3		33		63		93		123		153		183
	4		34		64		94		124		154		184
4	5		35		65		95		125		155		185
5	6		36		66		96		126		156		186
6	(7)		37		67		97		127		157		187
7	8		38		68		98		128		158		188
8	9		39		69		99		129		159		189
	10		40		70		100		130		160		190
9	11		41		71		101		131		161		191
10	12		42		72		102		132		162		192
11	(13)		43		73		103		133		163		193
15	(14)		44		74		104		134		164		194
	15		45		75		105		135		165		195
20	(16)		46		76		106		136		166		196
21	17		47		77		107		137		167		197
12	18		48		78		108		138		168		198
	19		49		79		109		139		169		199
13	20		50		80		110		140		170		200
14	21		51		81		111		141		171		201
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17	23		53		83		113		143		173		203
	24		54		84		114		144		174		204
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19	26		56		86		116		146		176		206
	27		57		87		117		147		177		207
	28		58		88		118		148		178		208
	29		59		89		119		149		179		209
	30		60		90		120		150		180		210